

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	79051	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram image or imaging or imager	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:20
L2	1246279		EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:20
L3	25236	microscope or microscopic or microscopically	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L4	1015690	semiconductor or wafer or substrate or mask or die or reticle	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L5	84764	align or aligning or aligner or alignment	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L6	641008	detector or sensor or "ccd"	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:21
L7	24374	magnify or magnification or magnifying	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L8	632670	switch or switching or shutter or shuttering	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L9	230	complex with phase with amplitude	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L10	12011	1 and 2	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:22
L11	405	10 and 5	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:41
L12	147	10 and 7	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:23
L13	789	10 and 8	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L14	0	11 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L15	0	12 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L16	0	13 and 9	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:40
L17	29	11 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:41
L18	34	linnik	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:43
L19	33	12 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:42
L20	13	13 and 3	EPO; JPO; IBM_TDB	OR	ON	2005/11/07 12:42
S1	389	(356/450).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/11/04 13:55

S2	50	(356/456).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 11:32
S3	79	(356/489).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:19
S4	90	(356/495).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:24
S5	208	(356/511).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 13:34
S6	301	(356/512).CCLS.	US-PGPUB; USPAT	OR	OFF	2005/10/20 14:06
S7	686773	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/07 12:20
S8	799365	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/07 12:20
S9	199634	microscope or microscopic or microscopically	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S10	1289596	semiconductor or wafer or substrate or mask or die or reticle	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S11	154761	S7 and S8	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S12	30278	S11 and S9	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S14	24878	S12 and S10	US-PGPUB; USPAT	OR	ON	2005/10/20 14:10
S15	733953	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S16	12719	S14 and S15	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S17	856040	complex or imaginary	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S18	8909	S16 and S17	US-PGPUB; USPAT	OR	ON	2005/10/20 14:11
S19	1264	"356"/\$.ccls. and S16	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S20	1048	"250"/\$.ccls. and S16	US-PGPUB; USPAT	OR	ON	2005/10/20 14:41
S21	540	"356"/\$.ccls. and S18	US-PGPUB; USPAT	OR	ON	2005/10/20 18:51
S22	366	"250"/\$.ccls. and S18	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S23	686773	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52

S24	799365	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S25	199634	microscope or microscopic or microscopically	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S26	1289596	semiconductor or wafer or substrate or mask or die or reticle	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S27	154761	S23 and S24	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S28	30278	S27 and S25	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S29	24878	S28 and S26	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S30	733953	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S31	12719	S29 and S30	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S32	856040	complex or imaginary	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S33	8909	S31 and S32	US-PGPUB; USPAT	OR	ON	2005/10/20 18:52
S34	164	"356"/450-521.ccls. and S33	US-PGPUB; USPAT	OR	ON	2005/10/20 18:54
S35	3	("4818110" "6078392" "6262818"). PN.	US-PGPUB; USPAT	OR	ON	2005/10/21 09:45
S36	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/03 15:41
S37	736612	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/03 15:41
S38	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S39	4424	S36 with S37 with S38	US-PGPUB; USPAT	OR	ON	2005/11/03 15:42
S40	860	"356"/\$.ccls. and S39	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S41	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S42	1699	S39 and S41	US-PGPUB; USPAT	OR	ON	2005/11/03 15:43
S43	532	"356"/\$.ccls. and S42	US-PGPUB; USPAT	OR	ON	2005/11/03 15:44
S44	397	"250"/\$.ccls. and S42	US-PGPUB; USPAT	OR	ON	2005/11/03 16:19
S45	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04

S46	736612	align or aligning or aligner or alignment	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S47	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S48	4424	S45 with S46 with S47	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S49	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S50	1699	S48 and S49	US-PGPUB; USPAT	OR	ON	2005/11/03 19:04
S51	97	"382"/\$.ccls. and S50	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S52	1	("re35350").PN.	US-PGPUB; USPAT	OR	OFF	2005/11/03 19:14
S53	5	("RE35350").URPN.	USPAT	OR	ON	2005/11/03 19:15
S54	6	("5276337").URPN.	USPAT	OR	ON	2005/11/03 19:15
S55	218	linnik	US-PGPUB; USPAT	OR	ON	2005/11/04 15:18
S56	21	("4732483").URPN.	USPAT	OR	ON	2005/11/04 14:04
S57	56	("5112129").URPN.	USPAT	OR	ON	2005/11/04 14:07
S58	49	("4818110").URPN.	USPAT	OR	ON	2005/11/04 14:09
S59	12	("5112125").URPN.	USPAT	OR	ON	2005/11/04 14:22
S60	95409	magnify or magnification	US-PGPUB; USPAT	OR	ON	2005/11/07 12:21
S61	803660	image or imaging or imager	US-PGPUB; USPAT	OR	ON	2005/11/04 14:22
S62	892306	detector or sensor or "ccd"	US-PGPUB; USPAT	OR	ON	2005/11/04 14:22
S63	4269	S60 with S61 with S62	US-PGPUB; USPAT	OR	ON	2005/11/04 14:23
S64	444	"382"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25
S65	597	"356"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S66	714	"250"/\$.ccls. and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S67	689734	interfer or interfere or interfering or interference or interferometer or interferometric or interferometrically or interferogram	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25
S68	1504	S67 and S63	US-PGPUB; USPAT	OR	ON	2005/11/04 14:25

S69	111	"382"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:26
S70	333	"356"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:37
S71	243	"250"/\$.ccls. and S68	US-PGPUB; USPAT	OR	ON	2005/11/04 14:55
S72	35	("4751376").URPN.	USPAT	OR	ON	2005/11/04 15:12
S73	160	S55 and S61	US-PGPUB; USPAT	OR	ON	2005/11/04 15:21
S74	1071558	switch or switching or shutter or shuttering	US-PGPUB; USPAT	OR	ON	2005/11/07 12:22
S75	42	S73 and S74	US-PGPUB; USPAT	OR	ON	2005/11/04 15:57
S76	5	(("6078392") or ("6262818") or ("5572598") or ("5583639") or ("5471303")).PN.	US-PGPUB; USPAT	OR	OFF	2005/11/04 15:57
S77	4166	complex with phase with amplitude	US-PGPUB; USPAT	OR	ON	2005/11/07 12:22
S78	1528	S61 and S77	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56
S79	1019	S67 and S78	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56
S80	12	S55 and S79	US-PGPUB; USPAT	OR	ON	2005/11/04 16:56